

Notice of References Cited	Application/Control No. 09/752,848	Applicant(s)/Patent Under Reexamination HONEA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,625,194 B1	09-2003	Kaneda, Yushi	372/71
	B	US-5,930,282 A	07-1999	Unternahrer et al.	372/69
	C	US-5,339,328 A	08-1994	Miura, Hiroshi	372/70
	D	US-5,299,220 A	03-1994	Brown et al.	372/71
	E	US-5,084,889	01-1992	Tajima, Hidemi	372/39
	F	US-4,912,713	03-1990	Langhans, Lutz	372/66
	G	US-4,681,396	07-1987	Jones, Marshall G.	385/33
	H	US-4,642,809	02-1987	Petheram, John C.	372/66
	I	US-4,555,786	11-1985	Byer, Robert L.	372/70
	J	US-4,207,541	06-1980	Karger et al.	372/35
	K	US-3,982,201	09-1976	Rosenkrantz et al.	372/75
	L	US-3,582,820	06-1971	Snitzer, Elias	372/68
	M	US-3,515,897	06-1970	Name not available	359/334

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2008314	11-1978	UK	William Burnett Jones	Ho1S 3/05
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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